Search Notes Application/Control No. Applicant(s)/Patent Under Reexamination LEE ET AL. Examiner Yuen, Kan Art Unit 2616

SEARCHED					
Class	Subclass	Date	Examiner		
370	204	5/10/2007	ky		
370	208	5/10/2007	ky		
370	328	5/10/2007	ky		
370	342	5/10/2007	ky		
370	335	5/10/2007	ky		
370	321	5/10/2007	ky		
370	330	5/10/2007	ky		
370	442	5/10/2007	ky		
370	465	5/10/2007	ky		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST SEARCH CONSULTED WITH SPE AND PRIMARY EXAMINER	5/10/2007	KY		
INVENTORSHIP SEARCH	5/10/2007	KY		
MANUAL SEARCH CLASS 370 SUBCLASS 335	5/10/2007	KY		
PLUS SEARCH	5/10/2007	KY		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
	INTERFERENCE SEARCH PRINTOUT (SEE SEARCH PRINTOUT)	2/25/2008	KY		

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